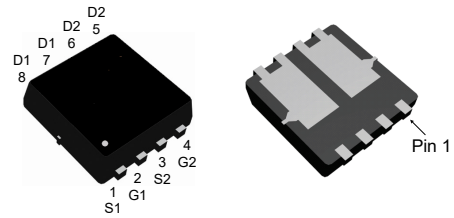


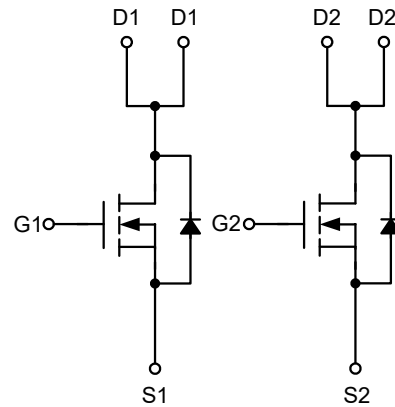
### Features

- 30V/35A
  - $R_{DS(ON)}=11m\Omega(\text{typ.})@V_{GS}=10V$
  - $R_{DS(ON)}=15m\Omega(\text{typ.})@V_{GS}=4.5V$
- 100% UIS +  $R_g$  Tested
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

### Pin Description



PDFN3.3\*3.3-8L



N-Channel MOSFET

### Applications

- Motor Control.
- High Current, High Speed Switching.
- Portable equipment application.

**Absolute Maximum Ratings** ( $T_A=25^\circ\text{C}$  Unless Otherwise Noted)

Symbol	Parameter		Rating	Unit
<b>Common Ratings</b>				
$V_{DSS}$	Drain-Source Voltage		30	V
$V_{GSS}$	Gate-Source Voltage		$\pm 20$	
$T_J$	Maximum Junction Temperature		150	$^\circ\text{C}$
$T_{STG}$	Storage Temperature Range		-55 to 150	
$I_S$	Diode Continuous Forward Current	$T_C=25^\circ\text{C}$	35	A
$I_D$	Continuous Drain Current	$T_C=25^\circ\text{C}$	35	A
		$T_C=100^\circ\text{C}$	19	
$I_{DM}^b$	Pulsed Drain Current	$T_C=25^\circ\text{C}$	75	A
$P_D$	Maximum Power Dissipation	$T_C=25^\circ\text{C}$	42	W
		$T_C=100^\circ\text{C}$	17	
$R_{\theta JC}$	Thermal Resistance-Junction to Case	Steady State	3	$^\circ\text{C}/\text{W}$
$R_{\theta JA}^c$	Thermal Resistance-Junction to Ambient	$t \leq 10\text{s}$	43	$^\circ\text{C}/\text{W}$
		Steady State	80	
$I_{AS}^d$	Avalanche Current, Single pulse	$L=0.1\text{mH}$	35	A
$E_{AS}^d$	Avalanche Energy, Single pulse	$L=0.1\text{mH}$	45	mJ

Note a : Maximum continuous current is limited by bonding wire.

Note b : Pulse width is limited by maximum junction temperature.

Note c : Surface mounted on  $1\text{in}^2$  pad area, steady state  $t = 999\text{s}$ .

Note d : UIS tested and pulse width limited by maximum junction temperature (initial temperature  $T_J=25^\circ\text{C}$ ).

**Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

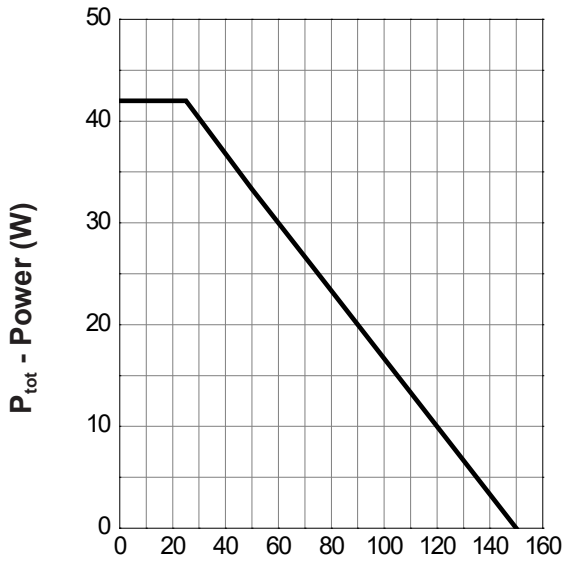
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_{DS}=250\mu A$	30	-	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=24V, V_{GS}=0V$	-	-	1	$\mu A$
		$T_J=85^\circ C$	-	-	30	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu A$	1.2	1.5	2	V
$I_{GSS}$	Gate Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	$\pm 100$	nA
$R_{DS(ON)}^e$	Drain-Source On-state Resistance	$V_{GS}=10V, I_{DS}=35A$	-	11	14	m $\Omega$
		$T_J=125^\circ C$	-	14.2	-	
		$V_{GS}=4.5V, I_{DS}=24A$	-	15	19	
Gfs	Forward Transconductance	$V_{DS}=5V, I_{DS}=2.4A$	-	8	-	S
<b>Diode Characteristics</b>						
$V_{SD}^e$	Diode Forward Voltage	$I_{SD}=1A, V_{GS}=0V$	-	0.7	1.1	V
$t_{rr}$	Reverse Recovery Time	$I_{SD}=4A, dI_{SD}/dt=100A/\mu s$	-	11	-	ns
$t_a$	Charge Time		-	6	-	
$t_b$	Discharge Time		-	5	-	
$Q_{rr}$	Reverse Recovery Charge		-	2	-	
<b>Dynamic Characteristics<sup>f</sup></b>						
$R_G$	Gate Resistance	$V_{GS}=0V, V_{DS}=0V, F=1MHz$	-	2.8	-	$\Omega$
$C_{iss}$	Input Capacitance	$V_{GS}=0V,$ $V_{DS}=15V,$ Frequency=1.0MHz	-	623	-	pF
$C_{oss}$	Output Capacitance		-	86	-	
$C_{riss}$	Reverse Transfer Capacitance		-	64	-	
$t_{d(ON)}$	Turn-on Delay Time	$V_{DD}=15V, R_L=15\Omega,$ $I_{DS}=1A, V_{GEN}=10V,$ $R_G=6\Omega$	-	11	20	ns
$t_r$	Turn-on Rise Time		-	7	13	
$t_{d(OFF)}$	Turn-off Delay Time		-	29	53	
$t_f$	Turn-off Fall Time		-	6	11	
<b>Gate Charge Characteristics<sup>f</sup></b>						
$Q_g$	Total Gate Charge	$V_{DS}=15V, V_{GS}=10V,$ $I_{DS}=4A$	-	11.3	-	nC
$Q_g$	Total Gate Charge	$V_{DS}=15V, V_{GS}=4.5V,$ $I_{DS}=4A$	-	6	11	
$Q_{gth}$	Threshold Gate Charge		-	1	-	
$Q_{gs}$	Gate-Source Charge		-	2	-	
$Q_{gd}$	Gate-Drain Charge		-	2.3	-	

 Note e : Pulse test ; pulse width $\leq 300\mu s$ , duty cycle $\leq 2\%$ .

Note f : Guaranteed by design, not subject to production testing.

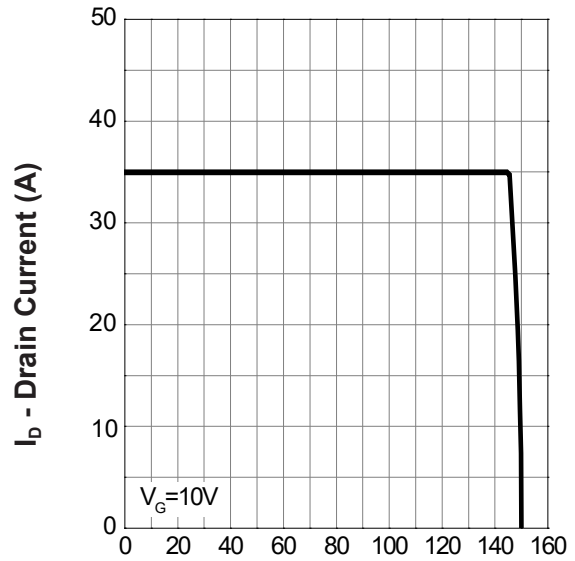
### Typical Operating Characteristics

**Power Dissipation**



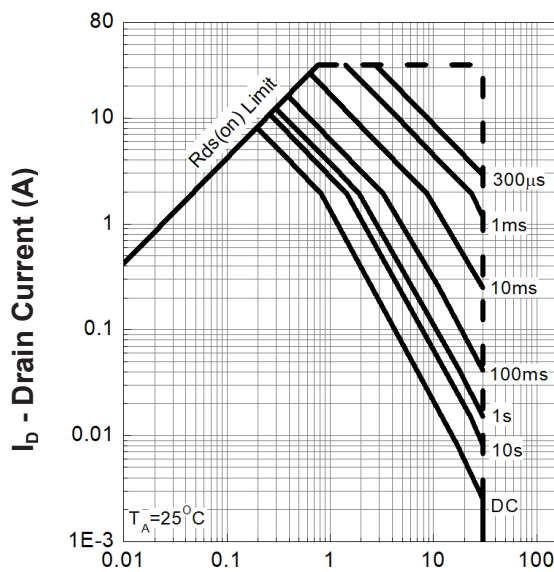
T<sub>c</sub> - Case Temperature (°C)

**Drain Current**



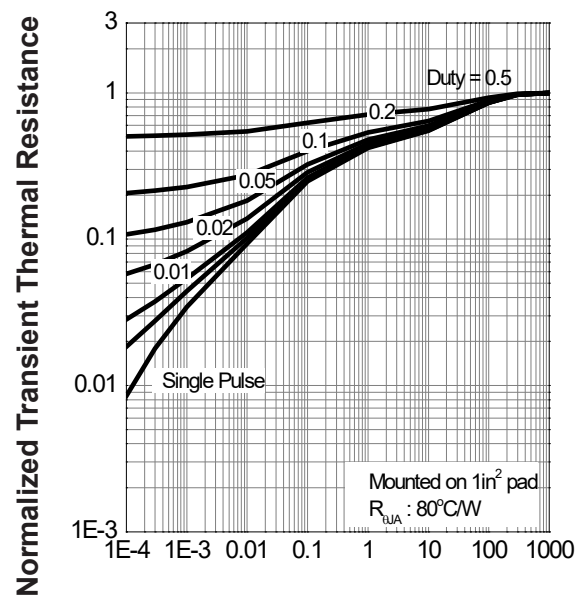
T<sub>c</sub> - Case Temperature (°C)

**Safe Operation Area**



V<sub>DS</sub> - Drain - Source Voltage (V)

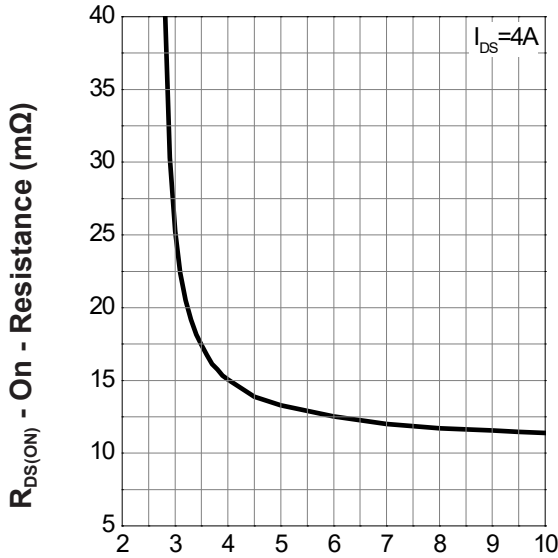
**Thermal Transient Impedance**



Square Wave Pulse Duration (sec)

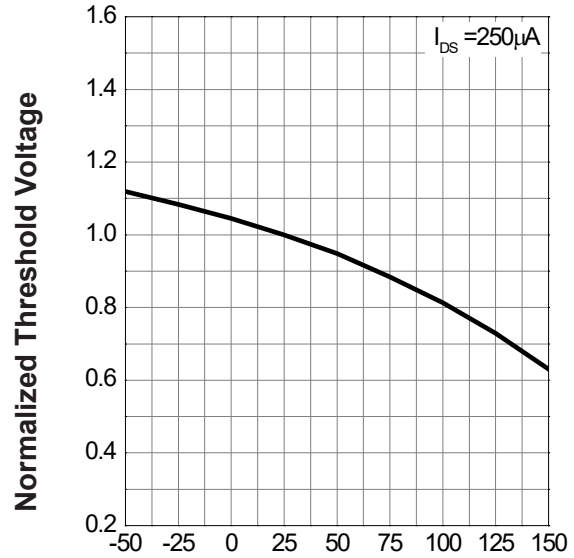
### Typical Operating Characteristics(Cont.)

Gate-Source On Resistance



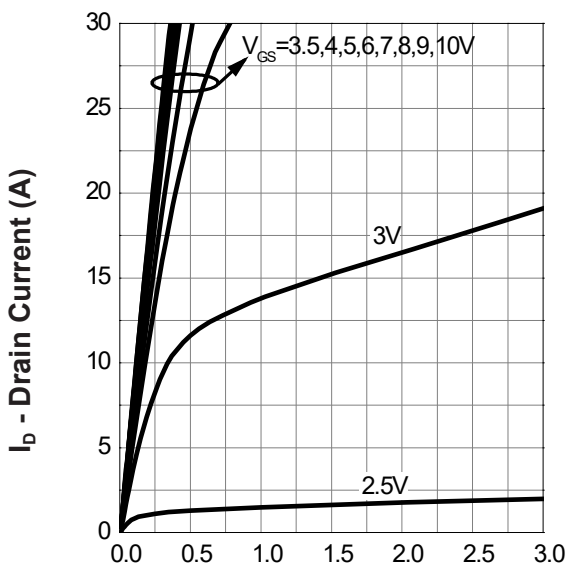
V<sub>GS</sub> - Gate - Source Voltage (V)

Gate Threshold Voltage



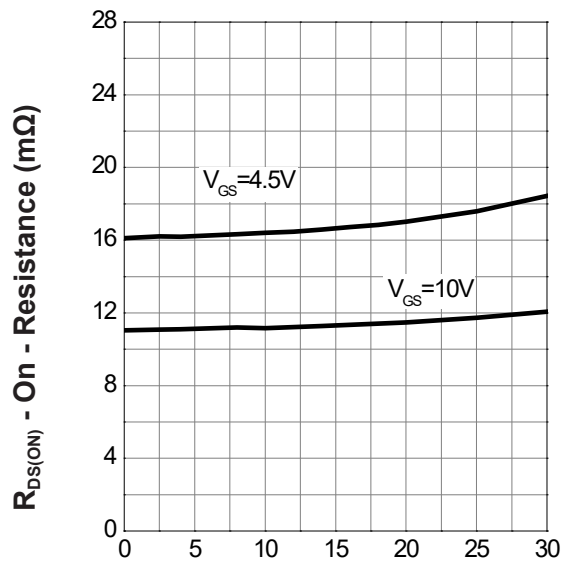
T<sub>J</sub> - Junction Temperature (°C)

Output Characteristics



V<sub>DS</sub> - Drain - Source Voltage (V)

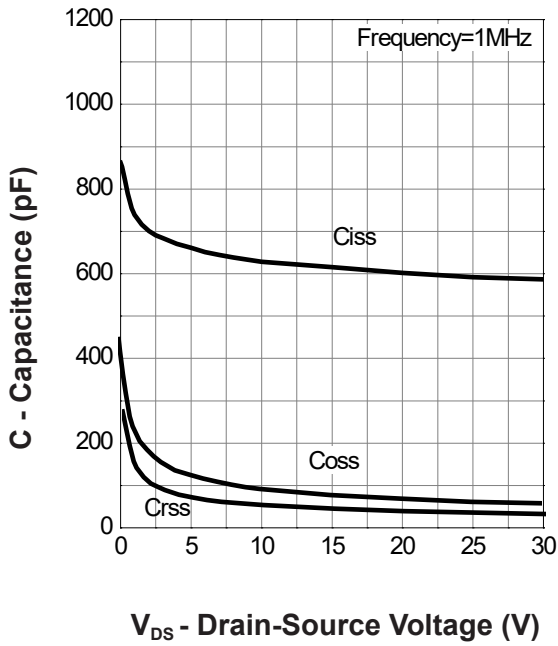
Drain-Source On Resistance



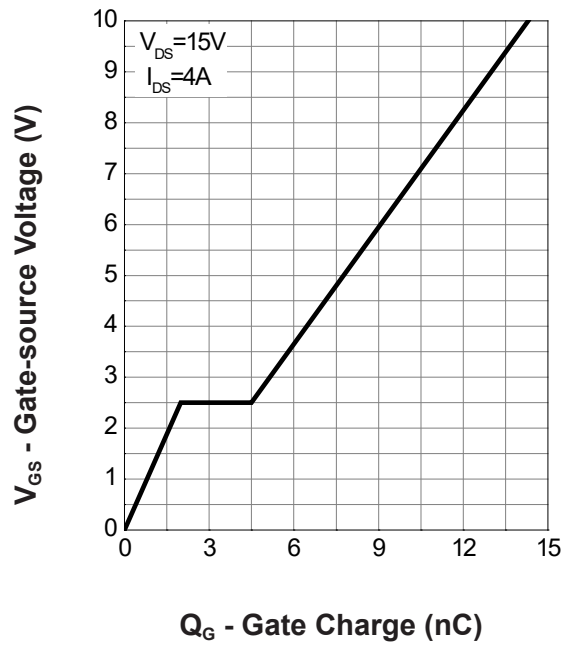
I<sub>D</sub> - Drain Current (A)

### Typical Operating Characteristics(Cont.)

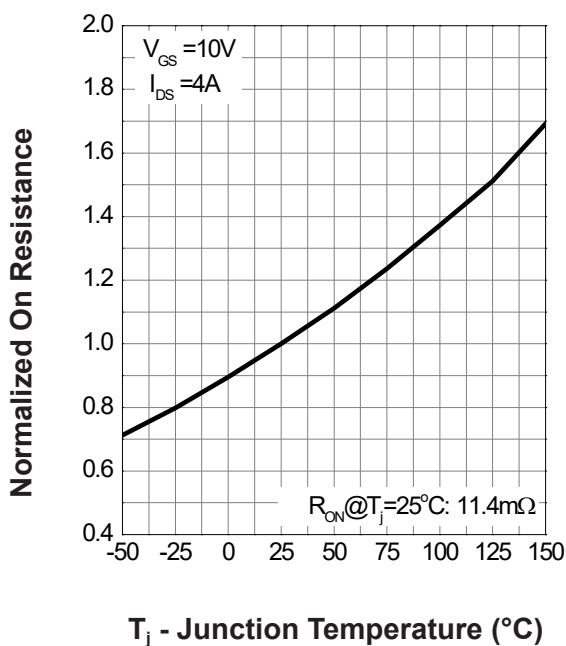
**Capacitance**



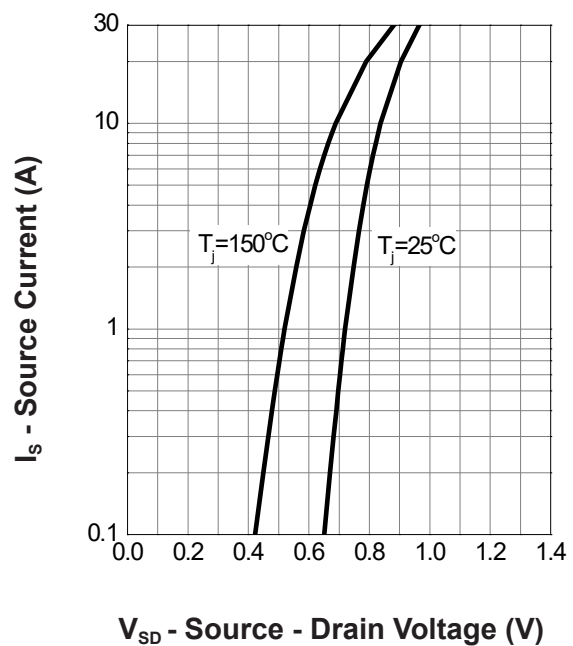
**Gate Charge**



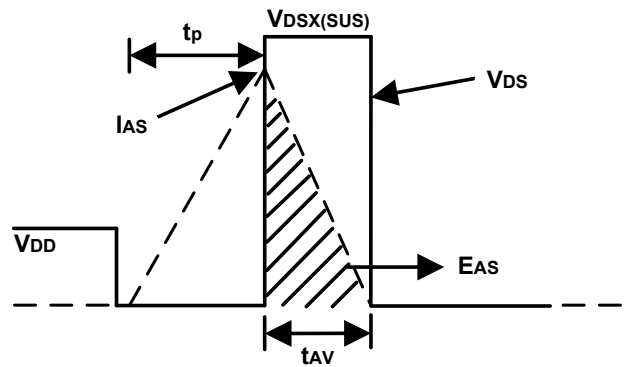
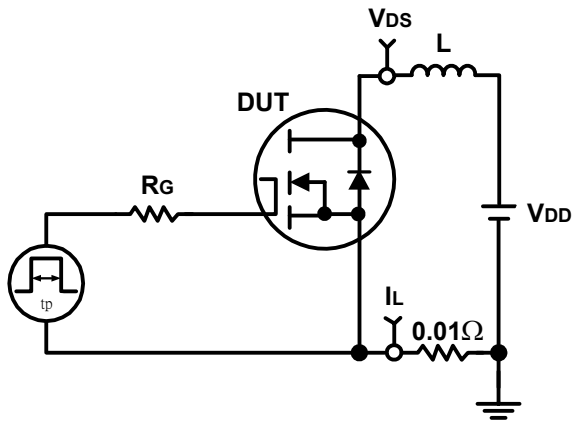
**Drain-Source On Resistance**



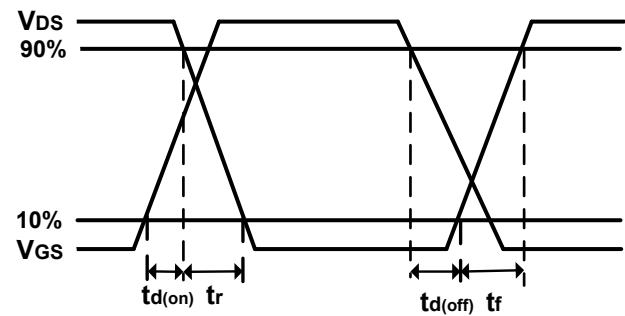
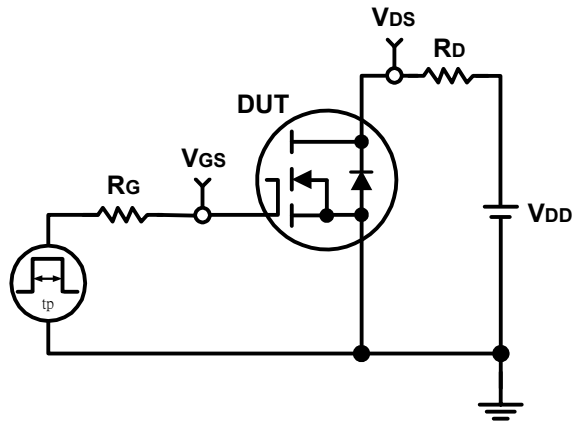
**Source-Drain Diode Forward**



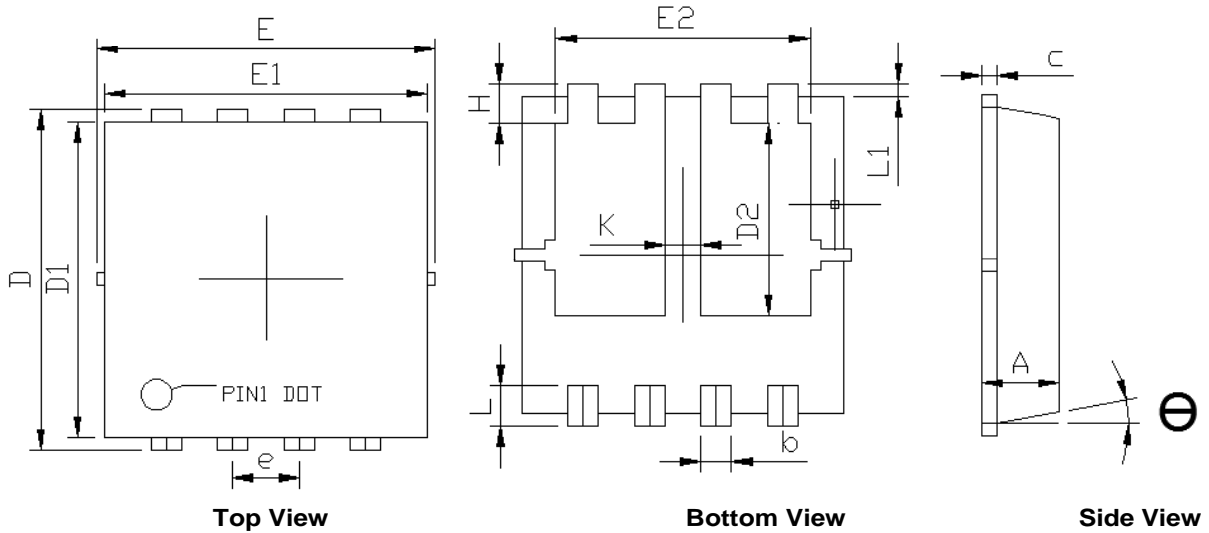
### Avalanche Test Circuit and Waveforms



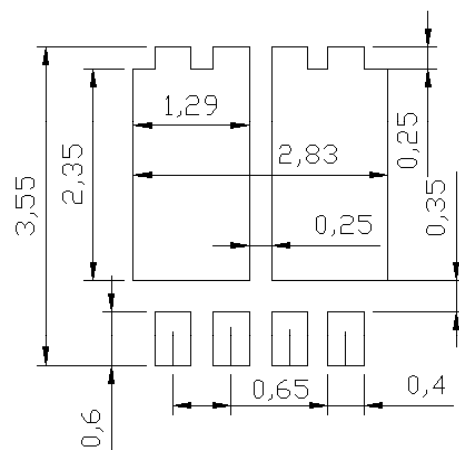
### Switching Time Test Circuit and Waveforms



## Package Information

**PDFN3.3\*3.3-8L**


SYMBOLS	RECOMMENDED LAND PATTERN			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	0.70	0.80	0.028	0.031
b	0.25	0.35	0.010	0.014
c	0.10	0.25	0.004	0.010
D	3.25	3.45	0.128	0.136
D1	3.00	3.20	0.118	0.126
D2	1.78	1.98	0.070	0.078
E	3.20	3.40	0.126	0.134
E1	3.00	3.20	0.118	0.126
E2	2.39	2.59	0.094	0.102
e	0.65BSC		0.026 BSC	
H	0.30	0.50	0.012	0.020
L	0.30	0.50	0.012	0.020
L1	0.13 REF		0.005 REF	
K	0.30	-	0.012	-
θ	-	12°	-	12°

**RECOMMENDED LAND PATTERN**


UNIT: mm